#1. IDS 6/30/03

INFORMATION CITED BY APPLICANT(S) THAT MAY BE MATERIAL TO THE PROSECUTION OF THE SUBJECT APPLICATION

Applicant:

R.B. Darling et al.

Attorney Docket No. UWOTL121266

Application No.: To Be Assigned

Group Art Unit: --

Filed:

Concurrently Herewith

Examiner: --

Title:

CHARGED PARTICLE BEAM DETECTION SYSTEM

U.S. PATENT DOCUMENTS

| *Examiner Initials | Cite No. | Document No. | Kind Code | Date (mm/dd/yyyy) | Name |
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| BES | U4 | 5,198,676 | | 03/30/1993 | Benveniste et al. |

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| *Examiner | Cite | | Kind | Publication Date | | Abstract | Translation |
| Initial | No. | Document No. | Code | (mm/dd/yyyy) | Country | Provided | Provided |

NONE

OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, Etc.)

| *Examiner | Cite |
|-----------|------|
| Initial | No. |

NONE

Examiner

Date Considered

*Examiner: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. GER:md

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#2 1DS 01/30/04

INFORMATION CITED BY APPLICANTS THAT MAY BE MATERIAL TO THE PROSECUTION OF THE SUBJECT APPLICATION

Applicants:

R.B. Darling et al.

Attorney Docket No. UWOTL121266

Application No.: 10/611,327

Group Art Unit: 2862

Filed:

June 30, 2003

Examiner: --

Title:

CHARGED PARTICLE BEAM DETECTION SYSTEM

U.S. PATENT DOCUMENTS

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OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, Etc.)

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NONE

Examiner

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FION CITED BY APPLICANTS THAT MAY BE MATERIAL TO THE PROSECUTION OF THE SUBJECT APPLICATION

Applicants:

R.B. Darling et al.

Attorney Docket No. UWOTL121266

Application No.: 10/611,327

Group Art Unit: 2862

Filed:

June 30, 2003

Confirmation No.: 3726

Title:

CHARGED PARTICLE BEAM DETECTION SYSTEM

U.S. PATENT DOCUMENTS

*Examiner Cite

Kind

Date

Initials

No. Document No. Code

(mm/dd/yyyy)

Name

NONE

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